



 We need a quantitative measure of complexity in order to be able to relate the training error (which we can observe) and the test error (that we'd like to optimize)



Finite case

- We'll start by considering only a finite number of possible classifiers, h₁(x),..., h_M(x) (e.g., randomly chosen linear classifiers)
- Key questions:
 - 1. Given n training examples and M possible classifiers how far can the training and test errors be?
 - 2. How many training examples do we need so that the errors are close?
 - The answers will depend on M.



Finite case: definitions

$$\hat{\mathcal{E}}_{n}(i) = \frac{1}{n} \sum_{t=1}^{n} \underbrace{\mathsf{Loss}(y_{t}, h_{i}(\mathbf{x}_{t}))}_{t=1}^{n} = \text{empirical error of } h_{i}(\mathbf{x})$$
$$\mathcal{E}(i) = E_{(\mathbf{x}, y) \sim P} \{ \mathsf{Loss}(y, h_{i}(\mathbf{x})) \} = \text{expected error of } h_{i}(\mathbf{x})$$



Finite case: definitions

$$\hat{\mathcal{E}}_{n}(i) = \frac{1}{n} \sum_{t=1}^{n} \underbrace{\mathsf{Loss}(y_{t}, h_{i}(\mathbf{x}_{t}))}_{t=1} = \text{empirical error of } h_{i}(\mathbf{x})$$
$$\mathcal{E}(i) = E_{(\mathbf{x}, y) \sim P} \{ \mathsf{Loss}(y, h_{i}(\mathbf{x})) \} = \text{expected error of } h_{i}(\mathbf{x})$$

• Suppose we choose the classifier that minimizes the training error, $\hat{i}_n = \arg\min_{i=1,...,M} \hat{\mathcal{E}}_n(i)$, then

Training error $= \hat{\mathcal{E}}_n(\hat{i}_n)$ Test error $= \mathcal{E}(\hat{i}_n)$



Finite case: errors

• The training and test errors,

Training error
$$= \hat{\mathcal{E}}_n(\hat{i}_n)$$

Test error $= \mathcal{E}(\hat{i}_n)$

are necessarily close if we can show that the errors are close for all the classifiers in our set:

$$|\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| \le \epsilon$$
, for all $i = 1, \dots, M$

• We can now express our key questions more formally in terms of $n,\ M,$ and ϵ



Finite case: key questions revisited

- Key questions (rewritten):
 - 1. Given n training examples and M possible classifiers, what is the smallest ϵ such that

$$\max_{i=1,\dots,M} |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| \le \epsilon$$

2. For a given ϵ how many training examples do we need so that

$$\max_{i=1,\dots,M} |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| \le \epsilon$$

Since training examples are sampled at random from some underlying distribution, we can only answer these questions probabilistically.



Finite case: errors



Finite case: probabilistic statement

• We can relate n, M, and ϵ by requiring that with high probability, the empirical errors of all the classifiers in our set are ϵ -close to their expected errors:

$$P\left(\max_{i=1,\dots,M} |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| \le \epsilon\right) \ge 1 - \delta$$

The probability is taken over the choice of the training set and $1-\delta$ specifies our confidence in the probabilistic statement.



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• Equivalently, we can bound the probability that the empirical error of some classifier in our set deviates more than ϵ from the expected error:

$$P\left(\max_{i=1,\dots,M} |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right) \le \delta$$



Finite case cont'd

 \bullet Let's fix $n,~M,~{\rm and}~\epsilon$ and try to find δ so that

$$P\left(\max_{i=1,\dots,M} |\hat{\mathcal{E}}_n(i) - \mathcal{E}(i)| > \epsilon\right) \le \delta$$

still holds. The probability is take over the choice of the training set.

By using the fact that $P(A \text{ or } B) \leq P(A) + P(B)$ we get

$$P\left(\max_{i} |\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right) \leq \sum_{i=1}^{M} P\left(|\hat{\mathcal{E}}_{n}(i) - \mathcal{E}(i)| > \epsilon\right)$$
$$\leq \sum_{i=1}^{M} 2\exp(-2n\epsilon^{2}) \quad \text{(Chernoff)}$$
$$= M \cdot 2\exp(-2n\epsilon^{2}) = \delta$$



Finite case cont'd

• We are now able to relate $n,~M,~\epsilon,~{\rm and}~\delta:$

$$M \cdot 2 \exp(-2n\epsilon^2) = \delta$$
, or $\epsilon = \sqrt{\frac{\log(M) + \log(2/\delta)}{2n}}$

• We can restate our result in terms of a bound on the expected error of any classifier in our set.

Theorem: With probability at least $1 - \delta$ over the choice of the training set, for all $i = 1, \ldots, M$

$$\mathcal{E}(i) \le \hat{\mathcal{E}}_n(i) + \epsilon(n, M, \delta)$$

where $\epsilon = \epsilon(n,M,\delta)$ is a "complexity penalty".



Measures of complexity

- Typically the set of classifiers is not a finite nor a countable set (e.g., the set of linear classifiers)
- There are still many ways of trying to capture the "effective" number of classifiers in such a set:
 - degrees of freedom (number of parameters)
 - Vapnik-Chervonenkis (VC) dimension
 - description length

etc.



VC-dimension: preliminaries

• A set of classifiers F: For example, this could be the set of all possible linear classifiers, where $h \in F$ means that

$$h(\mathbf{x}) = \operatorname{sign}\left(w_0 + \mathbf{w}_1^T \mathbf{x}\right)$$

for some values of the parameters w_0, \mathbf{w}_1 .



VC-dimension: preliminaries

• Complexity: how many different ways can we label n training points $\{\mathbf{x}_1, \ldots, \mathbf{x}_n\}$ with classifiers $h \in F$?

In other words, how many distinct binary vectors

$$[h(\mathbf{x}_1) h(\mathbf{x}_2) \dots h(\mathbf{x}_n)]$$

do we get by trying out each $h \in F$ in turn?

$$\begin{bmatrix} -1 & 1 & \dots & 1 &] & h_1 \\ [& 1 & -1 & \dots & 1 &] & h_2 \end{bmatrix}$$



VC-dimension: shattering

• A set of classifiers F shatters n points $\{\mathbf{x}_1, \ldots, \mathbf{x}_n\}$ if

 $[h(\mathbf{x}_1) h(\mathbf{x}_2) \dots h(\mathbf{x}_n)], h \in F$

generates all 2^n distinct labelings.

 Example: linear decision boundaries shatter (any) 3 points in 2D



but not any 4 points...



VC-dimension: shattering cont'd

 We cannot shatter any set of 4 points in 2D with linear classifiers. For example, we cannot generate the following XOR-labeling:



• More generally: the set of all d-dimensional linear classifiers can shatter exactly d + 1 points



VC-dimension: shattering cont'd

 We cannot shatter any set of 4 points in 2D with linear classifiers. For example, we cannot generate the following XOR-labeling:



- More generally: the set of all d-dimensional linear classifiers can shatter exactly d + 1 points
- **Definition:** The VC-dimension d_{VC} of a set of classifiers F is the number of points F can shatter



Learning and VC-dimension

• We learn something only after we no longer can shatter the training points (have more than d_{VC} training examples)

Rationale: suppose we have *n* training examples and labels $(\mathbf{x}_1, y_1), \ldots, (\mathbf{x}_n, y_n)$ and $n < d_{VC}$. Does the training set constrain our prediction for \mathbf{x}_{n+1} ?

Because we expect to be able to shatter n+1 points ($\leq d_{VC}$) it follows that we can find $h_1, h_2 \in F$, both consistent with training labels, but

$$h_1(\mathbf{x}_{n+1}) = 1, \quad h_2(\mathbf{x}_{n+1}) = -1$$

We therefore cannot determine which label to predict for \mathbf{x}_{n+1} .



Learning and VC-dimension

• We learn something only after we no longer can shatter the training points (have more than d_{VC} training examples)



Learning and VC-dimension

- By essentially replacing log M in the finite case with the log of the number of possible labelings by the set of classifiers over n (really 2n) points, we get an analogous result:
 - **Theorem**: With probability at least $1-\delta$ over the choice of the training set, for all $h \in F$

$$\varepsilon(h) \leq \hat{\varepsilon}_n(h) + \xi(n, d_{VC}, \delta)$$

$$\xi(n, d_{VC}, \delta) = \sqrt{\frac{d_{VC} \left(\log \frac{2n}{d_{VC}} + 1\right) + \log \frac{4}{\delta}}{n}}$$

Unfortunately, a loose bound

Model selection

- We try to find the model with the best balance of complexity and the fit to the training data
- Ideally, we would select a model from a nested sequence of models of increasing complexity
 - Model 1 d_1
 - Model 2 d_2
 - Model 3 d_3

where $d_1 \leq d_2 \leq d_3 \leq \ldots$

• Basic model selection criterion:

Criterion = (empirical) score + Complexity penalty

Structural risk minimization

• In structural risk minimization we define the models in terms of VC-dimension (or refinements)

Model 1 $d_{VC} = d_1$ Model 2 $d_{VC} = d_2$ Model 3 $d_{VC} = d_3$ where $d_1 < d_2 < d_3 < \dots$

• The selection criterion: lowest upper *bound* on the expected loss

Expected loss \leq Empirical loss + Complexity penalty

Example

- Models of increasing complexity
 - $\begin{array}{ll} \text{Model 1} & K(\mathbf{x}_1, \mathbf{x}_2) = (1 + (\mathbf{x}_1^T \mathbf{x}_2)) \\ \text{Model 2} & K(\mathbf{x}_1, \mathbf{x}_2) = (1 + (\mathbf{x}_1^T \mathbf{x}_2))^2 \\ \text{Model 3} & K(\mathbf{x}_1, \mathbf{x}_2) = (1 + (\mathbf{x}_1^T \mathbf{x}_2))^3 \end{array}$

• These are nested, i.e.,

. . .

. . .

$$F_1 \subseteq F_2 \subseteq F_3 \subseteq \ldots$$

where F_k refers to the set of possible decision boundaries that the model k can represent.

• Still need to derive the criterion...

Structural risk minimization cont'd

• For our zero-one loss (classification error), we can derive the following complexity penalty (Vapnik 1995):

$$\epsilon(n,\delta,d) = \sqrt{\frac{d_{VC}(\log(2n/d_{VC})+1) + \log(1/(4\delta))}{n}}$$

- 1. This is an increasing function of d_{VC}
- 2. Increases as δ decreases
- 3. Decreases as a function of \boldsymbol{n}

(this is not the only choice...)

Structural risk minimization cont'd

- Competition of terms...
 - 1. Empirical loss decreases with increasing d_{VC}
 - 2. Complexity penalty increases with increasing d_{VC}



• We find the minimum of the model score (bound).

Structural risk minimization: example



Structural risk minimization: example cont'd

• Number of training examples n = 50, confidence parameter $\delta = 0.05$.

Model	d_{VC}	Empirical fit	Complexity penalty $\epsilon(n, \delta, d_{VC})$
1^{st} order	3	0.06	0.5501
2^{nd} order	6	0.06	0.6999
4^{th} order	15	0.04	0.9494
8^{th} order	45	0.02	1.2849

• Structural risk minimization would select the simplest (linear) model in this case.



- X = R(e.g., heights of people)
- *H* is the set of hypotheses of the form *a* < *x* <*b*
- Subset containing two instances S ={3.1, 5.7}

- Can S be shattered by H?
- Yes, e.g., (1<x<2), (1<x<4),(4<x<7),(1<x<7)
- Since we have found a set of two that can be shattered, VC(H)is at least two
- · However, no subset of size three can be shattered
- Therefore VC(H) =2
- Here |H| is infinite but VC(H)is finite

• • •

2. (T/F) If there exists a set of k instances that cannot be shattered by H, then VC(H) < k.

3. Give the VC dimension of the class: H is the set of all perceptrons in 2D plane, i.e. $H = \{h_w | h_w = \theta(w_0 + w_1 x_1 + w_2 x_2) \text{ where } \theta(z) = 1 \text{ iff } z \ge 0 \text{ otherwise } \theta_z = 0\}.$

4. H = Axis parallel rectangles in R2 What is the VC dimension of H?



(need to consider here 16 different rectangles)

Shows that VC(H)>=4

•But, no five instances can be shattered



Since, there can be at most 4 distinct extreme points (smallest or largest along some dimension) and these cannot be included (labeled +) without including the 5th point.

Therefore VC(H) = 4